

DATA SHEET

BUW12F; BUW12AF Silicon diffused power transistors

Product specification
Supersedes data of February 1996
File under Discrete Semiconductors, SC06

1997 Aug 14

Silicon diffused power transistors

BUW12F; BUW12AF

DESCRIPTION

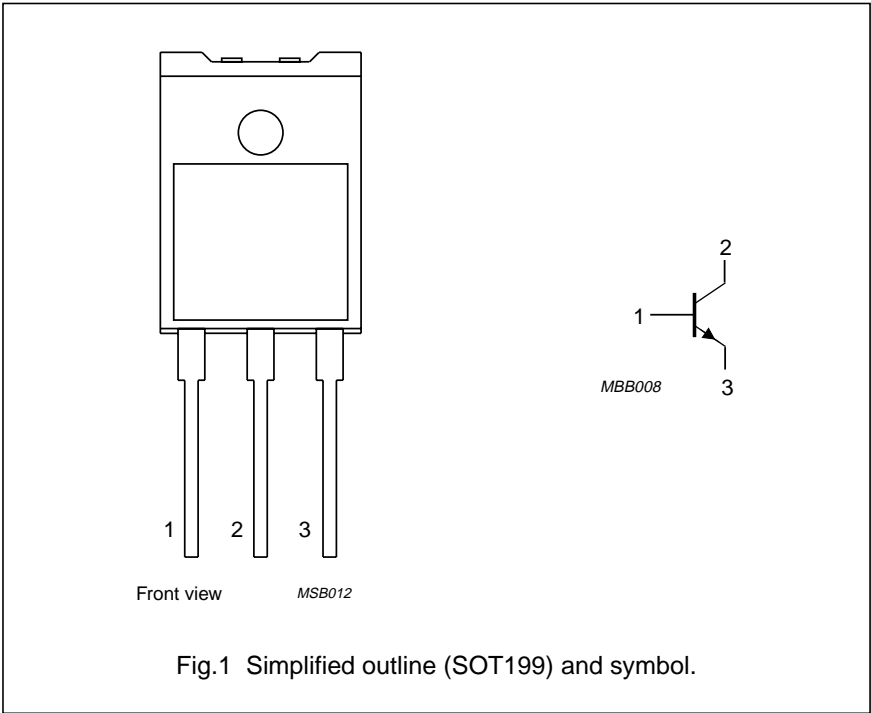
High-voltage, high-speed, glass-passivated NPN power transistor in a SOT199 package.

APPLICATIONS

- Converters
- Inverters
- Switching regulators
- Motor control systems.

PINNING

PIN	DESCRIPTION
1	base
2	collector
3	emitter
mb	mounting base; electrically isolated



QUICK REFERENCE DATA

SYMBOL	PARAMETER	CONDITIONS	MAX.	UNIT
V_{CESM}	collector-emitter peak voltage	$V_{BE} = 0$		
	BUW12F		850	V
	BUW12AF		1000	V
V_{CEO}	collector-emitter voltage	open base		
	BUW12F		400	V
	BUW12AF		450	V
V_{CEsat}	collector-emitter saturation voltage	see Figs 6 and 10	1.5	V
I_{Csat}	collector saturation current		6	A
			5	A
I_C	collector current (DC)	see Figs 2 and 5	8	A
I_{CM}	collector current (peak value)	see Fig 2	20	A
P_{tot}	total power dissipation	$T_h \leq 25\text{ }^{\circ}\text{C}$; see Fig.4	34	W
t_f	fall time	resistive load; see Figs 12 and 13	0.8	μs

Silicon diffused power transistors

BUW12F; BUW12AF

THERMAL CHARACTERISTICS

SYMBOL	PARAMETER	CONDITIONS	VALUE	UNIT
$R_{th\ j-h}$	thermal resistance from junction to external heatsink	note 1	3.7	K/W
		note 2	2.8	K/W
$R_{th\ j-a}$	thermal resistance from junction to ambient		35	K/W

Notes

1. Mounted **without** heatsink compound and 30 ± 5 N force on centre of package.
2. Mounted **with** heatsink compound and 30 ± 5 N force on centre of package.

LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 134).

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V_{CESM}	collector-emitter peak voltage BUW12F BUW12AF	$V_{BE} = 0$	—	850	V
			—	1000	V
V_{CEO}	collector-emitter voltage BUW12F BUW12AF	open base	—	400	V
			—	450	V
I_{Csat}	collector saturation current BUW12F BUW12AF	$V_{CE} = 1.5\text{ V}$	—	6	A
			—	5	A
I_C	collector current (DC)	see Figs 2 and 5	—	8	A
I_{CM}	collector current (peak value)	see Fig 2	—	20	A
I_B	base current (DC)		—	4	A
I_{BM}	base current (peak value)		—	6	A
P_{tot}	total power dissipation	$T_h \leq 25\text{ °C}$; see Fig.4; note 1	—	34	W
		$T_h \leq 25\text{ °C}$; see Fig.4; note 2	—	45	W
T_{stg}	storage temperature		−65	+150	°C
T_j	junction temperature		—	150	°C

Notes

1. Mounted **without** heatsink compound and 30 ± 5 N force on centre of package.
2. Mounted **with** heatsink compound and 30 ± 5 N force on centre of package.

ISOLATION CHARACTERISTICS

SYMBOL	PARAMETER	MAX.	UNIT
V_{isolM}	isolation voltage from all terminals to external heatsink (peak value)	1500	V
C_{isol}	isolation capacitance from collector to external heatsink	21	pF

Silicon diffused power transistors

BUW12F; BUW12AF

CHARACTERISTICS

$T_j = 25\text{ }^{\circ}\text{C}$ unless otherwise specified.

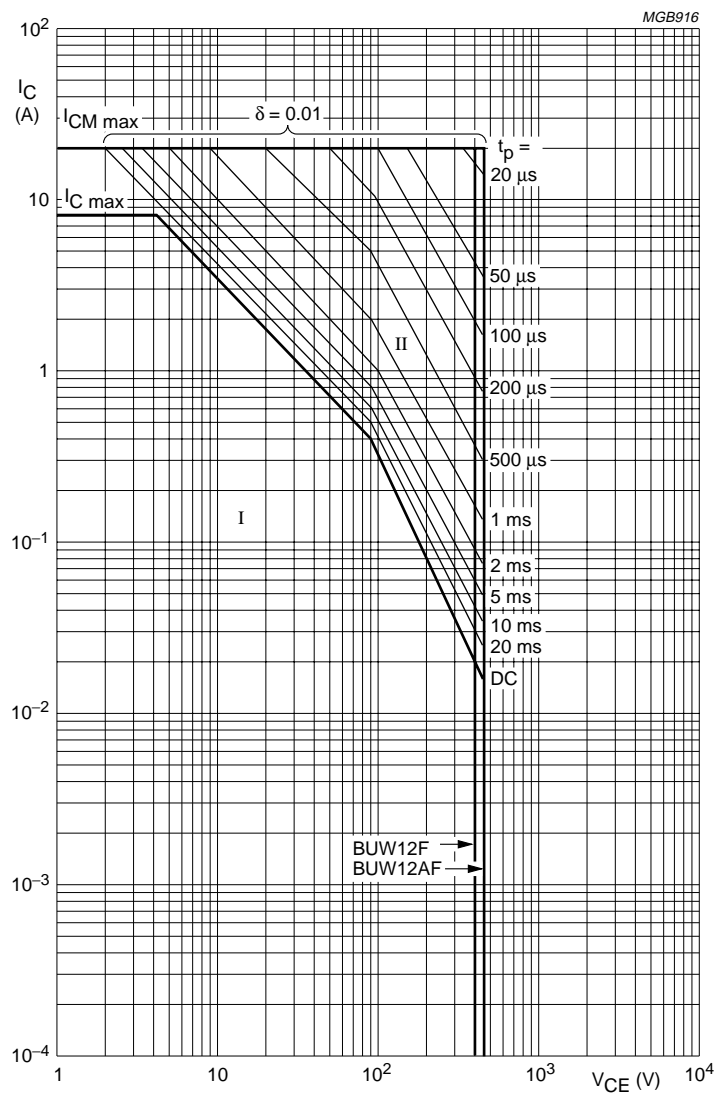
SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
$V_{CEOsust}$	collector-emitter sustaining voltage BUW12F BUW12AF	$I_C = 100\text{ mA}$; $I_{Boff} = 0$; $L = 25\text{ mH}$; see Figs 8 and 9	400 450	— —	— —	V V
V_{CEsat}	collector-emitter saturation voltage BUW12F BUW12AF	$I_C = 6\text{ A}$; $I_B = 1.2\text{ A}$; see Figs 6 and 10 $I_C = 5\text{ A}$; $I_B = 1\text{ A}$; see Figs 6 and 10	— —	— —	1.5 1.5	V V
V_{BEsat}	base-emitter saturation voltage BUW12F BUW12AF	$I_C = 6\text{ A}$; $I_B = 1.2\text{ A}$; see Fig.6 $I_C = 5\text{ A}$; $I_B = 1\text{ A}$; see Fig.6	— —	— —	1.5 1.5	V V
I_{CES}	collector-emitter cut-off current	$V_{CE} = V_{CESMmax}$; $V_{BE} = 0$; note 1 $V_{CE} = V_{CESMmax}$; $V_{BE} = 0$; $T_j = 125\text{ }^{\circ}\text{C}$; note 1	— —	— —	1 3	mA mA
I_{EBO}	emitter-base cut-off current	$V_{EB} = 9\text{ V}$; $I_C = 0$	—	—	10	mA
h_{FE}	DC current gain	$V_{CE} = 5\text{ V}$; $I_C = 10\text{ mA}$; see Fig.11 $V_{CE} = 5\text{ V}$; $I_C = 1\text{ A}$; see Fig.11	10 10	18 20	35 35	
Switching times resistive load (see Figs 12 and 13)						
t_{on}	turn-on time BUW12F BUW12AF	$I_{Con} = 6\text{ A}$; $I_{Bon} = I_{Boff} = 1.2\text{ A}$ $I_{Con} = 5\text{ A}$; $I_{Bon} = I_{Boff} = 1\text{ A}$	— —	— —	1 1	μs μs
t_s	storage time BUW12F BUW12AF	$I_{Con} = 6\text{ A}$; $I_{Bon} = I_{Boff} = 1.2\text{ A}$ $I_{Con} = 5\text{ A}$; $I_{Bon} = I_{Boff} = 1\text{ A}$	— —	— —	4 4	μs μs
t_f	fall time BUW12F BUW12AF	$I_{Con} = 6\text{ A}$; $I_{Bon} = I_{Boff} = 1.2\text{ A}$ $I_{Con} = 5\text{ A}$; $I_{Bon} = I_{Boff} = 1\text{ A}$	— —	— —	0.8 0.8	μs μs
Switching times inductive load (see Figs 14 and 15)						
t_s	storage time BUW12F BUW12AF	$I_{Con} = 6\text{ A}$; $I_B = 1.2\text{ A}$; $V_{CL} = 250\text{ V}$; $T_c = 100\text{ }^{\circ}\text{C}$ $I_{Con} = 5\text{ A}$; $I_B = 1\text{ A}$; $V_{CL} = 300\text{ V}$; $T_c = 100\text{ }^{\circ}\text{C}$	— —	1.9 1.9	2.5 2.5	μs μs
t_f	fall time BUW12F BUW12AF	$I_{Con} = 6\text{ A}$; $I_B = 1.2\text{ A}$; $V_{CL} = 250\text{ V}$; $T_c = 100\text{ }^{\circ}\text{C}$ $I_{Con} = 5\text{ A}$; $I_B = 1\text{ A}$; $V_{CL} = 300\text{ V}$; $T_c = 100\text{ }^{\circ}\text{C}$	— —	200 200	300 300	ns ns

Note

1. Measured with a half-sinewave voltage (curve tracer).

Silicon diffused power transistors

BUW12F; BUW12AF



Mounted **without** heatsink compound and 30 ± 5 N force on centre of package.

$T_{mb} < 25$ °C.

I - Region of permissible DC operation.

II - Permissible extension for repetitive pulse operation.

Fig.2 Forward bias SOAR.

Silicon diffused power transistors

BUW12F; BUW12AF

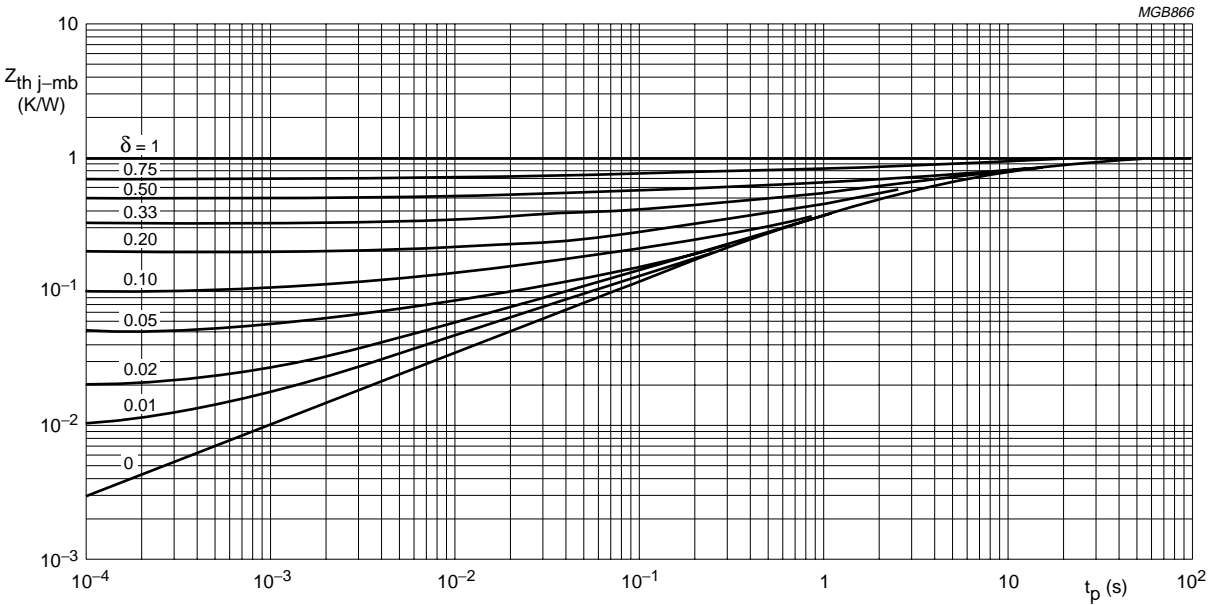


Fig.3 Transient thermal impedance.

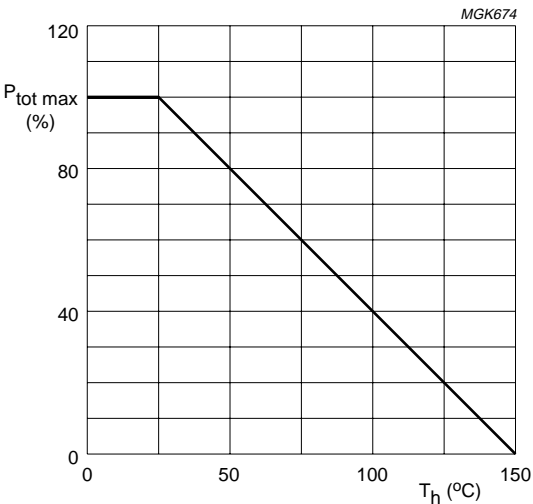
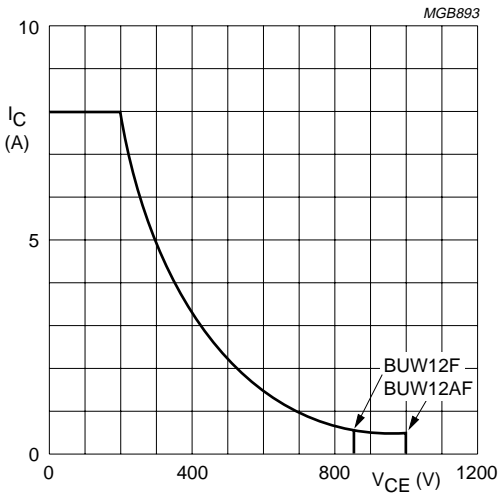


Fig.4 Power derating curve.

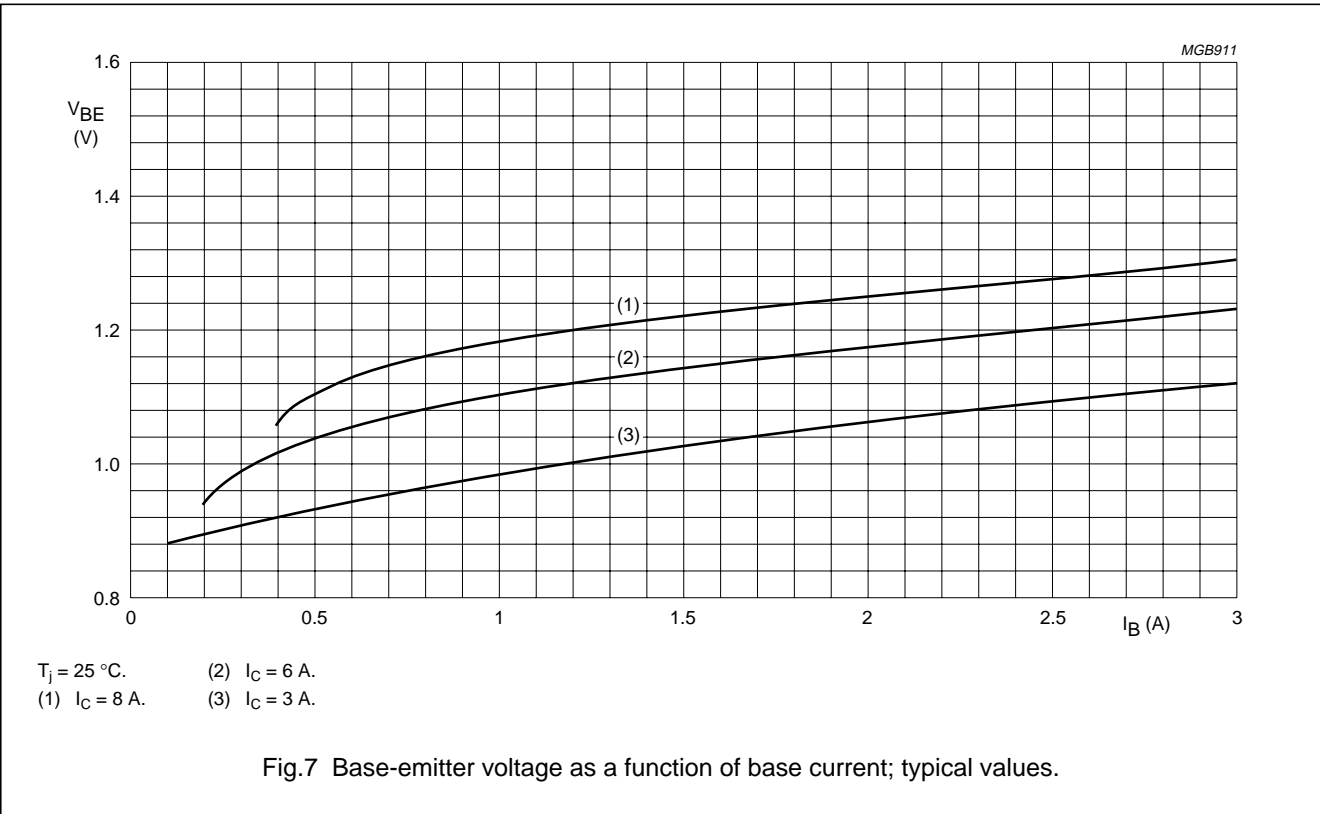
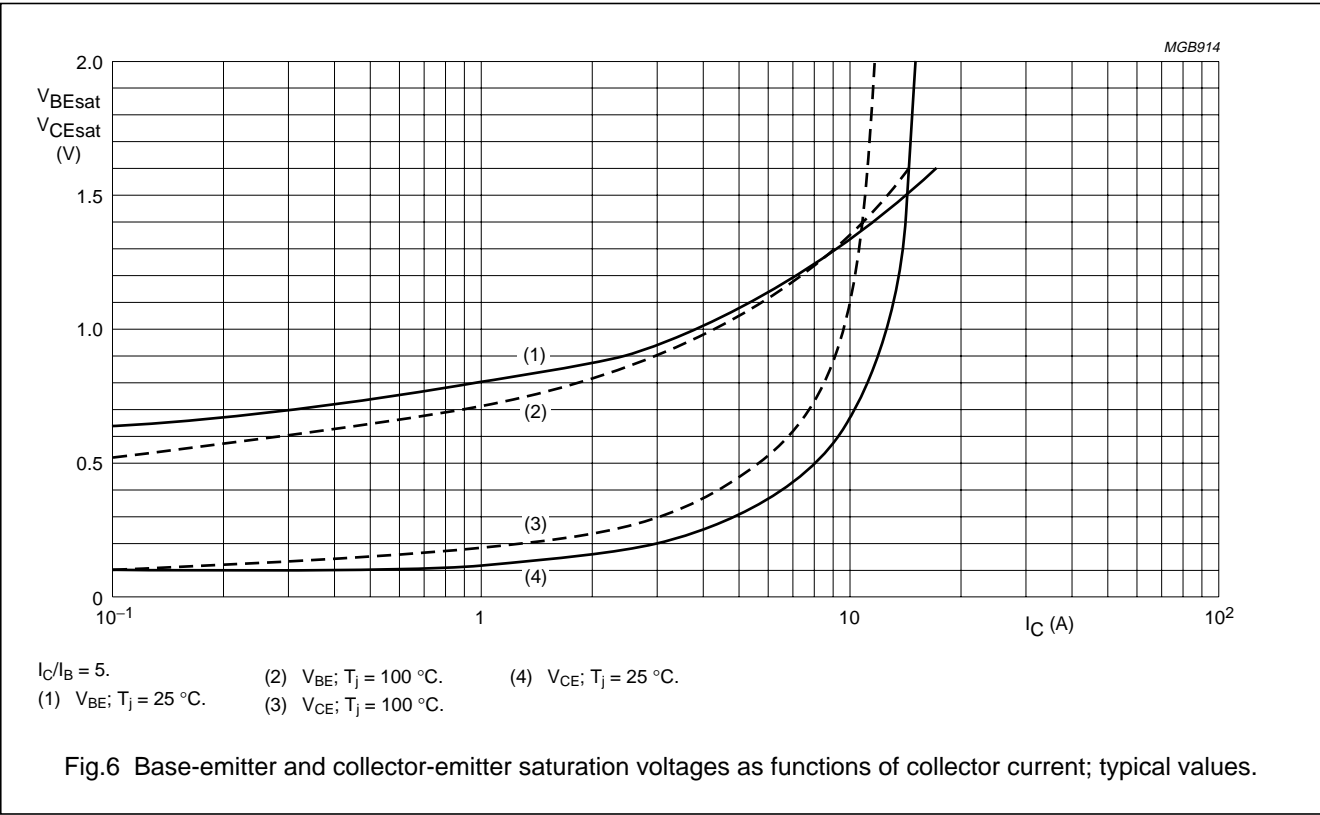


$T_c \leq 100\text{ }^{\circ}\text{C}$; $V_{BE} = -1\text{ to }-5\text{ V}$.

Fig.5 Reverse bias SOAR.

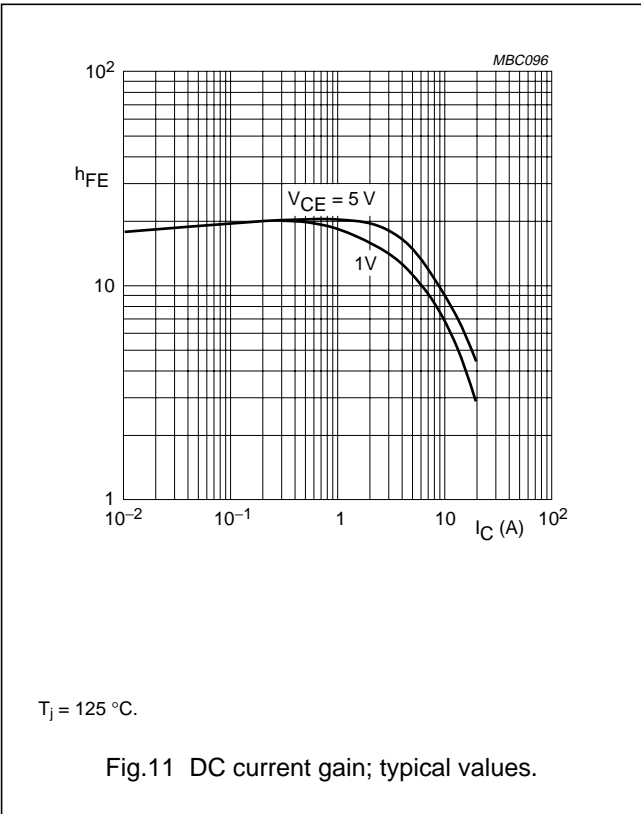
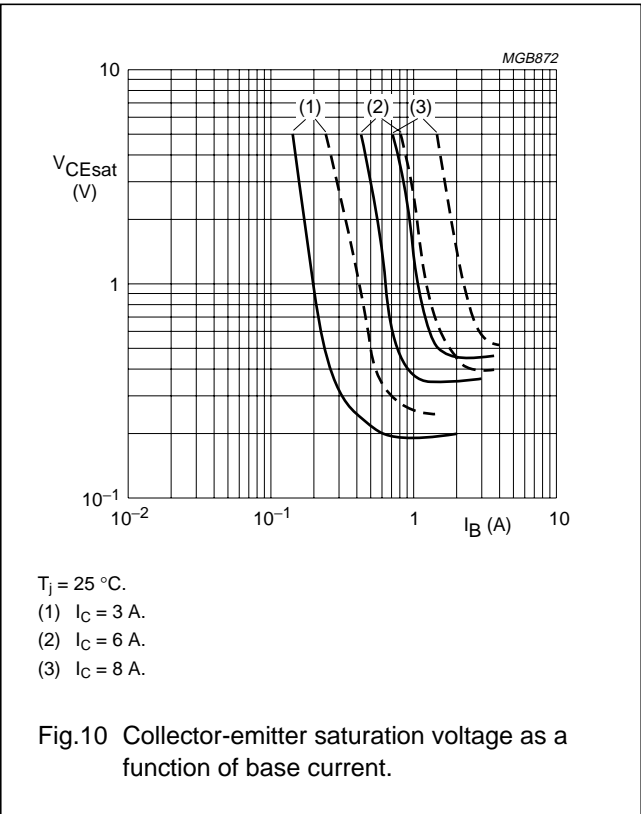
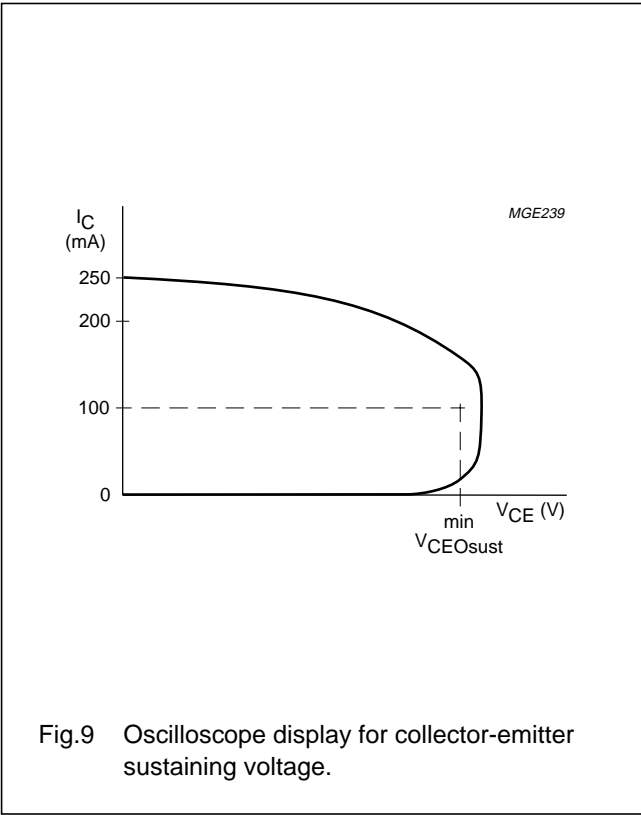
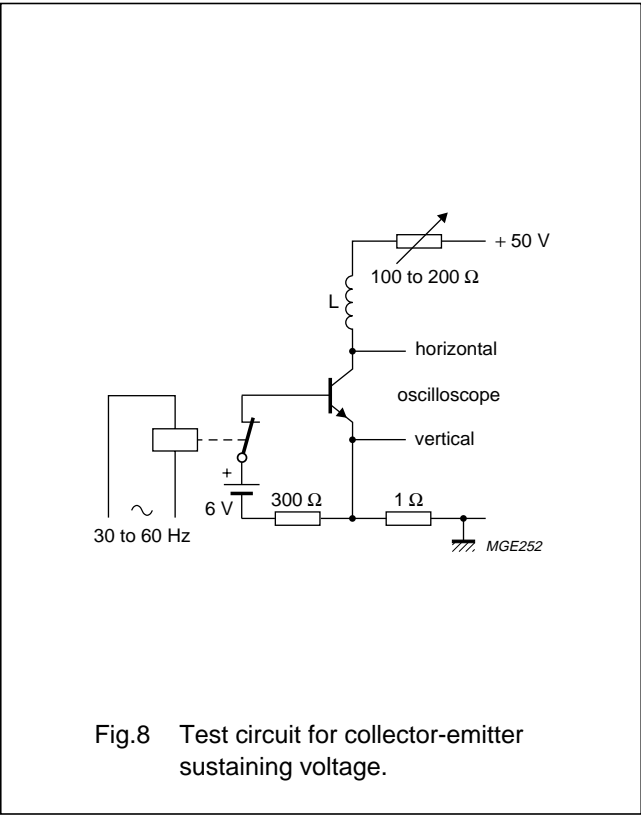
Silicon diffused power transistors

BUW12F; BUW12AF



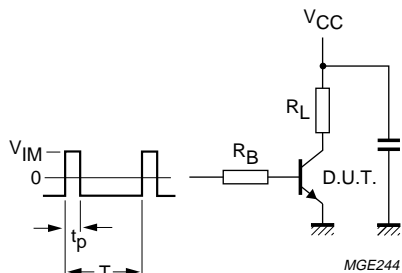
Silicon diffused power transistors

BUW12F; BUW12AF



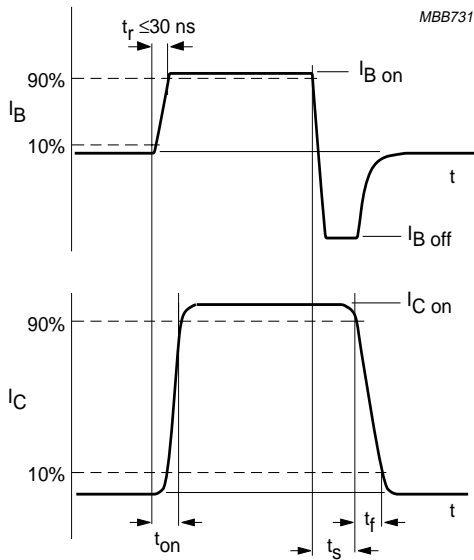
Silicon diffused power transistors

BUW12F; BUW12AF



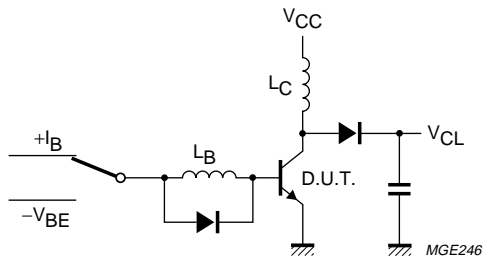
$V_{CC} = 250\text{ V}$; $t_p = 20\text{ }\mu\text{s}$; $V_{IM} = -6\text{ to }+8\text{ V}$; $t_p/T = 0.01$.
The values of R_B and R_L are selected in accordance with $I_{C\text{on}}$ and $I_{B\text{on}}$ requirements.

Fig.12 Test circuit resistive load.



$t_r \leq 20\text{ ns}$.

Fig.13 Switching time waveforms with resistive load.



$V_{CL} = \text{up to } 1000\text{ V}$; $V_{CC} = 30\text{ V}$; $V_{BE} = -1\text{ V to } -5\text{ V}$; $L_B = 1\text{ }\mu\text{H}$;
 $L_C = 200\text{ }\mu\text{H}$.

Fig.14 Test circuit inductive load and reverse bias SOAR.

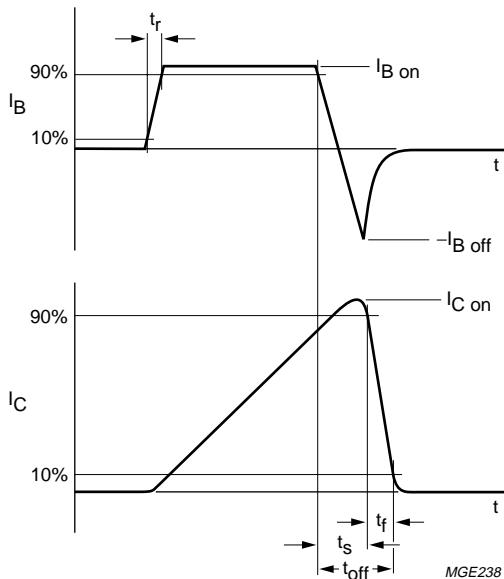


Fig.15 Switching time waveforms with inductive load.

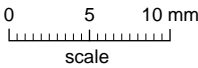
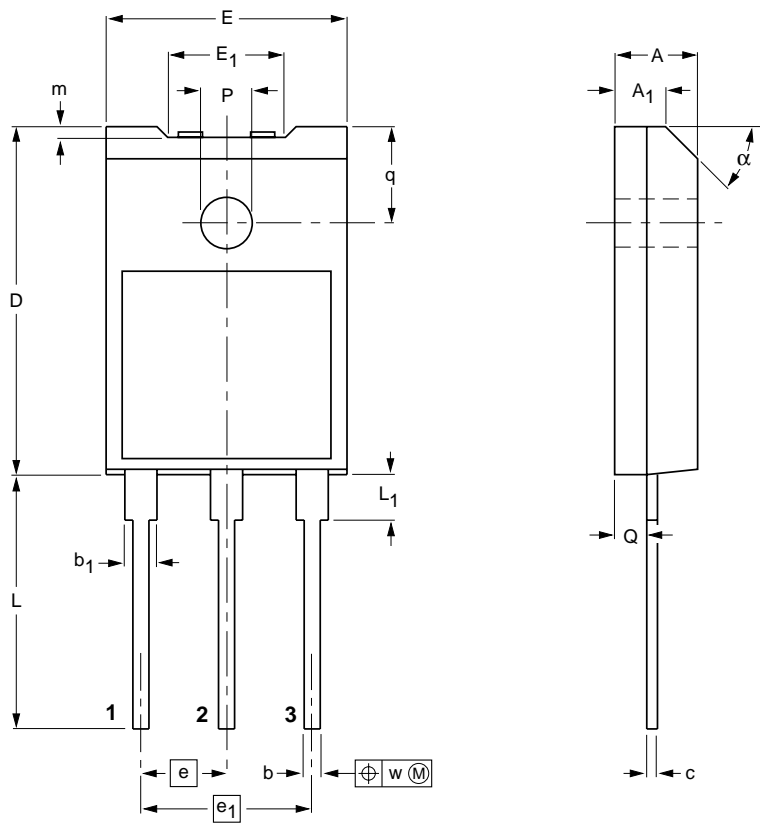
Silicon diffused power transistors

BUW12F; BUW12AF

PACKAGE OUTLINE

Plastic single-ended package; heatsink mounted; 1 mounting hole; 3 leads (in-line)

SOT199



DIMENSIONS (mm are the original dimensions)

UNIT	A	A ₁	b	b ₁	c	D	E	E ₁	e	e ₁	L	L ₁ ⁽¹⁾	m	P	Q	q	w	α
mm	5.2 4.8	3.4 3.0	1.2 1.0	2.1 1.9	0.6 0.5	21.5 20.5	15.3 14.7	7.8 6.8	5.45	10.9	16.5 15.7	3.7 3.3	0.8 0.6	3.3 3.1	2.1 1.9	6.2 5.8	0.4	45°

Note
1. Terminals in this zone are not tinned.

OUTLINE VERSION	REFERENCES				EUROPEAN PROJECTION	ISSUE DATE
	IEC	JEDEC	EIAJ			
SOT199						97-06-27

Silicon diffused power transistors

BUW12F; BUW12AF

DEFINITIONS

Data sheet status	
Objective specification	This data sheet contains target or goal specifications for product development.
Preliminary specification	This data sheet contains preliminary data; supplementary data may be published later.
Product specification	This data sheet contains final product specifications.
Limiting values	
Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of the specification is not implied. Exposure to limiting values for extended periods may affect device reliability.	
Application information	
Where application information is given, it is advisory and does not form part of the specification.	

LIFE SUPPORT APPLICATIONS

These products are not designed for use in life support appliances, devices, or systems where malfunction of these products can reasonably be expected to result in personal injury. Philips customers using or selling these products for use in such applications do so at their own risk and agree to fully indemnify Philips for any damages resulting from such improper use or sale.

Philips Semiconductors – a worldwide company

Argentina: see South America

Australia: 34 Waterloo Road, NORTH RYDE, NSW 2113,
Tel. +61 2 9805 4455, Fax. +61 2 9805 4466

Austria: Computerstr. 6, A-1101 WIEN, P.O. Box 213, Tel. +43 160 1010,
Fax. +43 160 101 1210

Belarus: Hotel Minsk Business Center, Bld. 3, r. 1211, Volodarski Str. 6,
220050 MINSK, Tel. +375 172 200 733, Fax. +375 172 200 773

Belgium: see The Netherlands

Brazil: see South America

Bulgaria: Philips Bulgaria Ltd., Energoprojekt, 15th floor,
51 James Bourchier Blvd., 1407 SOFIA,
Tel. +359 2 689 211, Fax. +359 2 689 102

Canada: PHILIPS SEMICONDUCTORS/COMPONENTS,
Tel. +1 800 234 7381

China/Hong Kong: 501 Hong Kong Industrial Technology Centre,
72 Tat Chee Avenue, Kowloon Tong, HONG KONG,
Tel. +852 2319 7888, Fax. +852 2319 7700

Colombia: see South America

Czech Republic: see Austria

Denmark: Prags Boulevard 80, PB 1919, DK-2300 COPENHAGEN S,
Tel. +45 32 88 2636, Fax. +45 31 57 0044

Finland: Sinikalliontie 3, FIN-02630 ESPOO,
Tel. +358 9 615800, Fax. +358 9 61580920

France: 4 Rue du Port-aux-Vins, BP317, 92156 SURESNES Cedex,
Tel. +33 1 40 99 6161, Fax. +33 1 40 99 6427

Germany: Hammerbrookstraße 69, D-20097 HAMBURG,
Tel. +49 40 23 53 60, Fax. +49 40 23 536 300

Greece: No. 15, 25th March Street, GR 17778 TAVROS/ATHENS,
Tel. +30 1 4894 339/239, Fax. +30 1 4814 240

Hungary: see Austria

India: Philips INDIA Ltd, Band Box Building, 2nd floor,
254-D, Dr. Annie Besant Road, Worli, MUMBAI 400 025,
Tel. +91 22 493 8541, Fax. +91 22 493 0966

Indonesia: see Singapore

Ireland: Newstead, Clonskeagh, DUBLIN 14,
Tel. +353 1 7640 000, Fax. +353 1 7640 200

Israel: RAPAC Electronics, 7 Kehilat Saloniki St, PO Box 18053,
TEL AVIV 61180, Tel. +972 3 645 0444, Fax. +972 3 649 1007

Italy: PHILIPS SEMICONDUCTORS, Piazza IV Novembre 3,
20124 MILANO, Tel. +39 2 6752 2531, Fax. +39 2 6752 2557

Japan: Philips Bldg 13-37, Kohnan 2-chome, Minato-ku, TOKYO 108,
Tel. +81 3 3740 5130, Fax. +81 3 3740 5077

Korea: Philips House, 260-199 Itaewon-dong, Yongsan-ku, SEOUL,
Tel. +82 2 709 1412, Fax. +82 2 709 1415

Malaysia: No. 76 Jalan Universiti, 46200 PETALING JAYA, SELANGOR,
Tel. +60 3 750 5214, Fax. +60 3 757 4880

Mexico: 5900 Gateway East, Suite 200, EL PASO, TEXAS 79905,
Tel. +9-5 800 234 7381

Middle East: see Italy

Netherlands: Postbus 90050, 5600 PB EINDHOVEN, Bldg. VB,
Tel. +31 40 27 82785, Fax. +31 40 27 88399

New Zealand: 2 Wagener Place, C.P.O. Box 1041, AUCKLAND,
Tel. +64 9 849 4160, Fax. +64 9 849 7811

Norway: Box 1, Manglerud 0612, OSLO,
Tel. +47 22 74 8000, Fax. +47 22 74 8341

Philippines: Philips Semiconductors Philippines Inc.,
106 Valero St. Salcedo Village, P.O. Box 2108 MCC, MAKATI,
Metro MANILA, Tel. +63 2 816 6380, Fax. +63 2 817 3474

Poland: Ul. Lukiska 10, PL 04-123 WARSZAWA,
Tel. +48 22 612 2831, Fax. +48 22 612 2327

Portugal: see Spain

Romania: see Italy

Russia: Philips Russia, Ul. Usatcheva 35A, 119048 MOSCOW,
Tel. +7 095 755 6918, Fax. +7 095 755 6919

Singapore: Lorong 1, Toa Payoh, SINGAPORE 1231,
Tel. +65 350 2538, Fax. +65 251 6500

Slovakia: see Austria

Slovenia: see Italy

South Africa: S.A. PHILIPS Pty Ltd., 195-215 Main Road Martindale,
2092 JOHANNESBURG, P.O. Box 7430 Johannesburg 2000,
Tel. +27 11 470 5911, Fax. +27 11 470 5494

South America: Rua do Rocio 220, 5th floor, Suite 51,
04552-903 São Paulo, SÃO PAULO - SP, Brazil,
Tel. +55 11 821 2333, Fax. +55 11 829 1849

Spain: Balmes 22, 08007 BARCELONA,
Tel. +34 3 301 6312, Fax. +34 3 301 4107

Sweden: Kottbygatan 7, Akalla, S-16485 STOCKHOLM,
Tel. +46 8 632 2000, Fax. +46 8 632 2745

Switzerland: Allmendstrasse 140, CH-8027 ZÜRICH,
Tel. +41 1 488 2686, Fax. +41 1 481 7730

Taiwan: Philips Semiconductors, 6F, No. 96, Chien Kuo N. Rd., Sec. 1,
TAIPEI, Taiwan Tel. +886 2 2134 2865, Fax. +886 2 2134 2874

Thailand: PHILIPS ELECTRONICS (THAILAND) Ltd.,
209/2 Sanpavuth-Bangna Road Prakanong, BANGKOK 10260,
Tel. +66 2 745 4090, Fax. +66 2 398 0793

Turkey: Talatpasa Cad. No. 5, 80640 GÜLTEPE/ISTANBUL,
Tel. +90 212 279 2770, Fax. +90 212 282 6707

Ukraine: PHILIPS UKRAINE, 4 Patrice Lumumba str., Building B, Floor 7,
252042 KIEV, Tel. +380 44 264 2776, Fax. +380 44 268 0461

United Kingdom: Philips Semiconductors Ltd., 276 Bath Road, Hayes,
MIDDLESEX UB3 5BX, Tel. +44 181 730 5000, Fax. +44 181 754 8421

United States: 811 East Arques Avenue, SUNNYVALE, CA 94088-3409,
Tel. +1 800 234 7381

Uruguay: see South America

Vietnam: see Singapore

Yugoslavia: PHILIPS, Trg N. Pasica 5/v, 11000 BEOGRAD,
Tel. +381 11 625 344, Fax. +381 11 635 777

For all other countries apply to: Philips Semiconductors, Marketing & Sales Communications,
Building BE-p, P.O. Box 218, 5600 MD EINDHOVEN, The Netherlands, Fax. +31 40 27 24825

Internet: <http://www.semiconductors.philips.com>

© Philips Electronics N.V. 1997

SCA55

All rights are reserved. Reproduction in whole or in part is prohibited without the prior written consent of the copyright owner.

The information presented in this document does not form part of any quotation or contract, is believed to be accurate and reliable and may be changed without notice. No liability will be accepted by the publisher for any consequence of its use. Publication thereof does not convey nor imply any license under patent- or other industrial or intellectual property rights.

Printed in The Netherlands

137067/00/01/pp12

Date of release: 1997 Aug 14

Document order number: 9397 750 02719

Let's make things better.

Philips
Semiconductors



PHILIPS